Sheet 1 of 1			·			·			
FORM PTO 1449 (modified)						RIAL NO. I3(b) Div of SN 09/654,043			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several stheets if necessary)			APPLICANT Ken TAKANO et al.						
			FILING DATE March 10, 2004			GROUP 3729			
U.S. PATENT DOCUMENTS									
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS		SUBCLASS	FILING DATE IF APPROPRIATE		
ga	4,706,187	11/1987	Arai et al.	364		191			
ga	5,579,572	12/1996	Kashiwagi et al.	29		838			
ga	5,379,514	01/1995	Okuda et al.	29		833	-		
Oja	5,033,185	07/1991	Hidese	29		740			
Opa	5,070,598	12/1991	Itagaki et al.	29		700			
Oja	5,235,164	08/1993	Noyama et al.	235		375			
oza	5,255,429	10/1993	Nishi et al.	29		720			
Qª	5,588,195	12/1996	Asai et at.	29		33M			
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Ofa	6,002,650	12/1999	Kuribayashi et al.	367		488.24			
Cla	6,259,966	09/2001	Izumida et al.	700		229			
ya	6,259,966	09/2001	Maenishi et al.	29		832			
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS		SUBCLASS	TRANSLATION NO YES		
ga	03-149603	08/26/1991	Japan	_				Abstract	
<u>ya</u>	1081998	07/2001	European						
Sja	2001-119196	04/2001	Japan	_			V		
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OTHER DOCUMENT(S) flackeding Author, Title, Date, Pertinent Pages, Etc.)									
EXAMINER: (5) (1) Per DATE CONSIDERED: 6/23/6/									

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 603; Oraw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.